

TCAD simulation III

E. Giulio Villani

Overview

- **Simulation example of 2D PN junction using SDEVICE**
- **Charge generation and collection**

TCAD simulation SDEVICE

TCAD Synopsys Simulation

- **Sentaurus Device** is a numeric semiconductor device simulator, capable of simulating the electrical, thermal, and optical characteristics of various semiconductor devices.
- It simulates 1D, 2D, and 3D device behaviour over a wide range of operating conditions, including mixed-mode circuit simulation, combining numerically simulated devices with their compact modeling, which is performed on a SPICE-based circuit simulation level.

1 **File Section:** input/output files

2 **Electrode Section:** electrode definition, matching those in the input grid

3 **Physics Section:** physics models to use in the simulation

4 **Plot Section:** variables to plot

5 **Math Section:** solvers

6 **Solve Section:** what to solve (IV,CV, Charge injection)

A typical command file of Sentaurus Device consists of several sections (or statement blocks), with each section executing a relatively independent function. The default extension of the command file is `_des.cmd`, for example, `pp1_des.cmd`. To start: **sdevice**



TCAD Synopsys Simulation

- SDEVICE simulation of 2D pn junction
 - **Charge generation**
- **Within SDEVICE, charge injection by particles can be modelled using the models for carrier generation by gamma radiation, alpha particles and heavy ions (optical generation is also available)**
- **HeavyIon generation:**

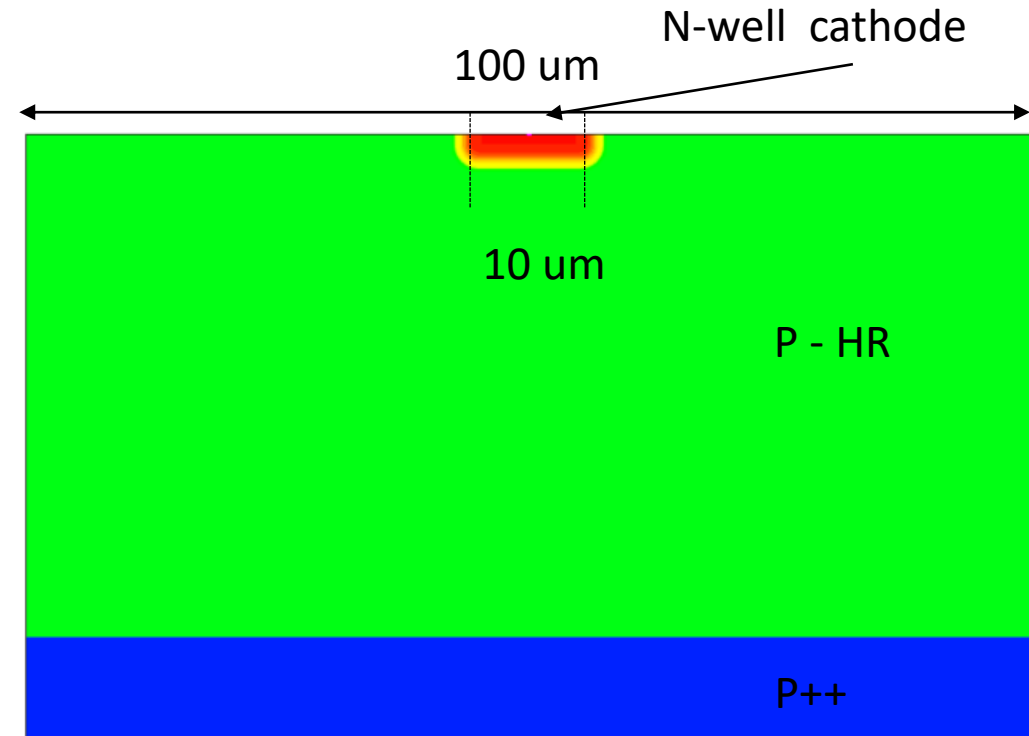
$$G(l,w,t)=G_{let}(l)R(w,l)T(t)$$

G_{let} : linear energy transfer(LET) generation density

$R(w,t)$: spatial distribution (exponential/Gaussian)

$T(t)$: temporal profile

				
TwoDsde	sdeviceV_REV	deviceV_FWD	deviceCV_RE	sdeviceCCE
	Temp			Vbias
	[n2] 280	[n6] --	[n9] --	[n15] --
				[n12] 100



TCAD Synopsys Simulation

- SDEVICE command file: transient analysis:
- - **File Section:** input/output files
 - **Electrode Section:** electrode definition, matching those in the input grid
 - **Physics Section:** physics models to use in the simulation
 - **System:** defines a mixed mode setup consisting of the device(s) and sources attached to it
 - **Plot Section:** variables to plot
 - **Math Section:** solvers to use

```
#####      2D PN junction CCE analysis      #####

#define Vdd @Vbias@
#define HitTime 1e-8
#define HitTime_Step 1e-11
#define Transient_Time 5e-9

## Input and Output Files

Device PNjct {
                                File {
                                    grid = "2D_PNjct_msh.tdr"
                                }
}
```

TCAD Synopsys Simulation

- SDEVICE command file: physics section
 - **The ionisation is obtained by a Minimum Ionising Particle (MIP)**
 - **Details of the ionisation are included in a file (MIP_EXC) which has the LET and spatial parameters required for MIP emulation**

```
Physics {  
  
#####if "@Ionization@"=="MIP"  
  
#include "MIP_EXC"  
  
...  
  
#define WT_hi 0.1  
  
        Heavylon (  
Time = HitTime  
Location = (0, 0) ### Hits at the top surface, right in the middle of the device  
Direction = (1.0,0.0)      ### Perpendicular hit  
  
###LET_f = [1.28e-5 1.28e-5 1.28e-5] ### 80 e/h per micron is 1.28E-5 for THICK sensor  
LET_f = [1.056e-5 1.056e-5 1.056e-5] ### 66 e/h per micron as MPV for 50 um thick  
active region  
### LET_f = [1.15e-5 1.15e-5 1.15e-5] ### 72 e/h per micron as MPV for 300 um thick  
active region  
  
Wt_hi = [WT_hi WT_hi WT_hi] ###      ro = 0.1/0.2 micron  
Length = [ 0.0 20 60 ] ### LET @ different depths, irrelevant for a MIP  
PicoCoulomb  
Gaussian  
  
        )
```

TCAD Synopsys Simulation

- SDEVICE command file: solve
 - The voltage is first ramped up to the required bias voltage
 - Then the transient simulation starts
 - The time resolution is increase just before the hit

Solve procedure

Solve {

```
Coupled(Iterations= 700 LineSearchDamping= 1e-4){ Poisson }
```

```
Coupled(Iterations= 70 LineSearchDamping= 1e-4){ Poisson Electron Hole }
```

DC bias

```
NewCurrentPrefix="2D_PNjct_Temp@Temp@_CCE_DCVbias@Vbias@"
```

ramps up to the max Vbias for CCE investigation

```
Quasistationary  
( InitialStep= 1e-3 MinStep= 1e-15 MaxStep= 0.25  
  Increment= 2.0 Decrement= 4.0  
  Goal { Parameter = vc.dc voltage = Vdd }  
)  
  { Coupled { Poisson Electron Hole } }
```

Starts the transient

```
NewCurrentPrefix="2D_PNjct_Temp@Temp@_CCE_TRVbias@Vbias@"
```

initial reset time until HIT_Time - 10ps...

```
Transient ( InitialTime = 0 FinalTime = @<HitTime-0.01e-9>@  
  InitialStep = 1e-9 MaxStep = 2e-9  
  MinStep = 1e-15 )  
  {  
    Coupled (Iterations = 10 ) { Poisson Electron Hole }  
  }
```


TCAD Synopsys Simulation

- SDEVICE command file: solve
 - When the particle hits the devices, the temporal resolution is optimised for the first ns, it is relaxed afterwards

```
### starts the transient analysis in 'HiRes' , set by Hit_Time_Step, until Hit_time + 1 ns

                                Transient (   InitialTime = @<HitTime-0.01e-9>@
FinalTime = @<HitTime+1e-9>@
                                InitialStep = 0.1e-12 MaxStep
= HitTime_Step MinStep = 1e-15 )
                                {   Coupled (Iterations = 5 ) { Poisson
Electron Hole }

                                Plot ( FilePrefix =
"2D_PNjct_Temp@Temp@_CCE_TRVbias@Vbias@"

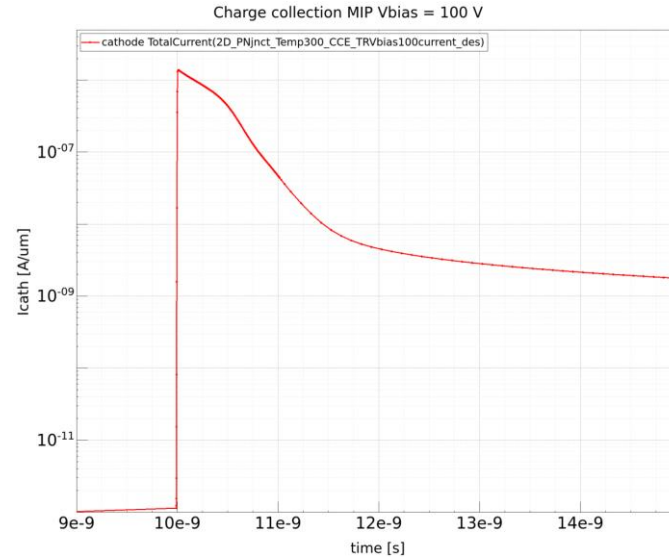
                                Time = (
                                HitTime
                                ) NoOverwrite )
                                }

### after the first 1 ns after the hit the transient is in 'MediumRes' of 0.1 ns

                                Transient (   InitialTime = @<HitTime+1e-9>@ FinalTime =
@<HitTime+Transient_Time>@
                                InitialStep = 1e-12 MaxStep =
.1e-9 MinStep = 1e-15 )
                                {
                                Coupled (Iterations = 10 ) { Poisson
Electron Hole }
```

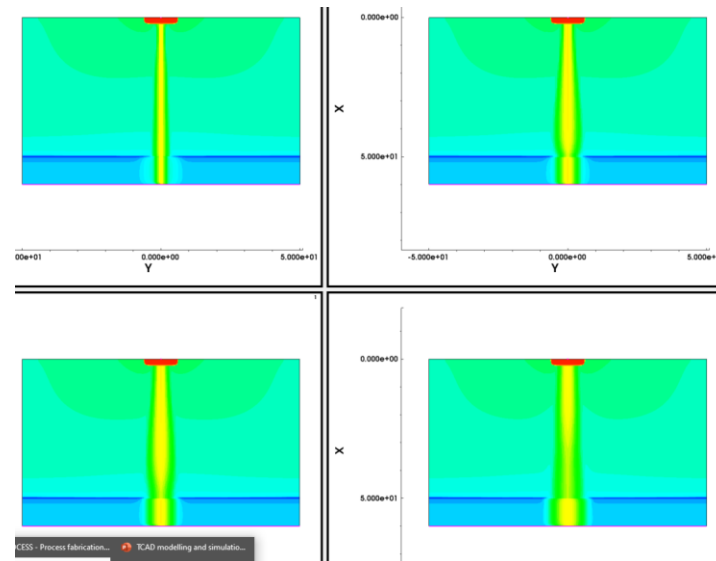
TCAD Synopsys Simulation

- Visualize the resulting mesh using **SVISUAL**
 - Re-mesh the structure changing the p – doping
 - Visualise the meshing
 - I transient vs. bias
 - Charge collected vs. bias
 - Plots of charge density vs. time



Icathode transient
– MIP hit @ 10 ns -:
No Ramo’s theorem used

$$Q = \oint \epsilon \vec{E} \cdot d\vec{S}$$



Icathode transient
– MIP hit @ 0, 100,200,500 ps

Thank you

giulio.villani@stfc.ac.uk

- Simulation example : 2D pn using SDEVICE
- Charge generation and collection from MIP hit